



Agilent Technologies

Sample ID:2019-01-30T11-58-50

Sample Scans:30

Background Scans:8

Resolution:4

System Status:Good

File Location:C:\Users\Public\Documents\Agilent\MicroLab\Results\2019-01-30T11-58-50.a2r

Method Name:Plastic analysis

User:Admin

Date/Time:01/30/2019 11:58:50 AM

Range:4000 - 650

Apodization:Happ-Genzel

